CMOS Digital Integrated Circuits Silicon Monolithic

7UL2G126FK

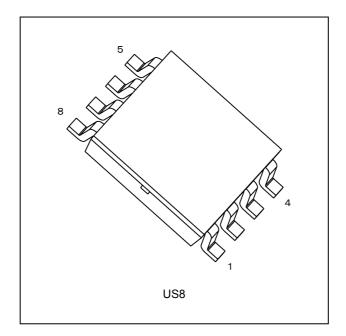
1. Functional Description

• Dual Bus Buffer with 3-State Output

2. Features

- (1) Wide operating temperature range: $T_{opr} = -40$ to 125 °C
- (2) High output current: $\pm 8.0 \text{ mA}$ (min) at V_{CC} = 3.0 V
- (3) Super high speed operation: t_{pd} = 2.9 ns (typ.) at V_{CC} = 3.3 V, C_L = 15 pF
- (4) Operation voltage range: V_{CC} = 0.9 to 3.6 V
- (5) 3.6 V tolerant inputs
- (6) 3.6 V power down protection output

3. Packaging



4. Marking and Pin Assignment



2021-12-24

Rev.2.0

5. IEC Logic Symbol



6. Truth Table

Input G	Input A	Output Y
L	Х	Z
н	L	L
Н	Н	Н

X: Don't care

Z: High impedance

7. Absolute Maximum Ratings (Note) (Unless otherwise specified, T_a = 25 °C)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V _{CC}		-0.5 to 4.6	V
Input voltage	V _{IN}		-0.5 to 4.6	V
DC output voltage	V _{OUT}	(Note 1)	-0.5 to 4.6	V
		(Note 2)	-0.5 to V _{CC} + 0.5	
Input diode current	I _{IK}		-20	mA
Output diode current	I _{ОК}	(Note 3)	-20	mA
DC output current	I _{OUT}		±25	mA
V _{CC} /ground current	I _{CC}		±50	mA
Power dissipation	PD		200	mW
Storage temperature	T _{stg}		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: V_{CC} = 0 V or high impedance condition

Note 2: High (H) or Low (L) state. I_{OUT} absolute maximum rating must be observed.

Note 3: V_{OUT} < GND

8. Operating Ranges (Note)

Characteristics	Symbol	Note	Test Condition	Rating	Unit
Supply voltage	V _{CC}		_	0.9 to 3.6	V
Input voltage	V _{IN}		_	0 to 3.6	V
Output voltage	V _{OUT}	(Note 1)	_	0 to 3.6	V
		(Note 2)	_	0 to V _{CC}	
Output current	I _{OH} ,I _{OL}		V _{CC} = 3.0 to 3.6 V	±8.0	mA
			V _{CC} = 2.3 to 2.7 V	±4.0	
			V _{CC} = 1.65 to 1.95 V	±3.0	
			V _{CC} = 1.4 to 1.6 V	±1.7	
			V _{CC} = 1.1 to 1.3 V	±0.3]
			V _{CC} = 0.9 V	±0.02	1
Operating temperature	T _{opr}		_	-40 to 125	°C
Input rise and fall time	dt/dv		V_{IN} = 0.8 to 2.0 V, V_{CC} = 3.0 V	0 to 10	ns/V

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either V_{CC} or GND.

Note 1: V_{CC} = 0 V or high impedance condition

Note 2: High (H) or Low (L) state.

9. Electrical Characteristics

9.1. DC Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Test Condition	1	V _{CC} (V)	Min	Тур.	Max	Unit
High-level input voltage	V _{IH}			0.9	V _{CC}	_	—	V
				1.1 to 1.3	$V_{CC} imes 0.70$	_	_	1
				1.4 to 1.6	$V_{CC} imes 0.65$	_	_	
				1.65 to 1.95	$V_{CC} imes 0.65$	_	_	1
				2.3 to 2.7	1.7	_	_]
				3.0 to 3.6	2.0	_	—	
Low-level input voltage	VIL	_		0.9	_	_	GND	V
				1.1 to 1.3	_	_	$V_{CC} \times 0.30$	
				1.4 to 1.6	_	_	$V_{CC} \times 0.35$	
				1.65 to 1.95	_	_	$V_{CC} \times 0.35$	
				2.3 to 2.7	_	_	0.7]
				3.0 to 3.6	_	_	0.8	
High-level output voltage	evel output voltage V_{OH} $V_{IN} = V_{IH}$	V _{IN} = V _{IH}	I _{OH} = -0.02 mA	0.9	0.75	_	_	V
			I _{OH} = -0.3 mA	1.1 to 1.3	$V_{CC} imes 0.75$	_	_]
			I _{OH} = -1.7 mA	1.4 to 1.6	$V_{CC} imes 0.75$	_	_	1
			I _{OH} = -3.0 mA	1.65 to 1.95	V _{CC} -0.45	_	_	
			I _{OH} = -4.0 mA	2.3 to 2.7	2.0	_	_]
			I _{OH} = -8.0 mA	3.0 to 3.6	2.48	_	_	1
Low-level output voltage	V _{OL}	$V_{IN} = V_{IH} \text{ or } V_{IL}$	I _{OL} = 0.02 mA	0.9	_	_	0.1	V
			I _{OL} = 0.3 mA	1.1 to 1.3	—	—	$V_{CC} \times 0.25$	
			I _{OL} = 1.7 mA	1.4 to 1.6	_	_	$V_{CC} \times 0.25$	
			I _{OL} = 3.0 mA	1.65 to 1.95	_	_	0.45	
			I _{OL} = 4.0 mA	2.3 to 2.7	—	_	0.4	
			I _{OL} = 8.0 mA	3.0 to 3.6	_	_	0.4	
Input leakage current	I _{IN}	V _{IN} = 0 to 3.6 V		0 to 3.6	_	_	±0.1	μA
3-state output OFF-state leakage current	I _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL},$ $V_{OUT} = 0 \text{ to } 3.6 \text{ V}$		0.9 to 3.6	—		±1.0	μA
Power-OFF leakage current	I _{OFF}	V _{IN} = 0 to 3.6 V, V _{OUT} = 0 to 3.6 V		0	—		1.0	μA
Quiescent supply current	I _{CC}	$V_{IN} = V_{CC}$ or GND		3.6	—		1.0	μA

9.2. DC Characteristics (Unless otherwise specified, $T_a = -40$ to 85 °C)

Characteristics	Symbol	Test Condition	1	V _{CC} (V)	Min	Max	Unit
High-level input voltage	V _{IH}	—		0.9	V _{CC}	_	V
				1.1 to 1.3	$V_{CC} \times 0.70$	—	
				1.4 to 1.6	$V_{CC} \times 0.65$	—	
				1.65 to 1.95	$V_{CC} \times 0.65$	_	
				2.3 to 2.7	1.7	—	
				3.0 to 3.6	2.0	_	
Low-level input voltage	VIL	—		0.9	—	GND	V
				1.1 to 1.3	_	$V_{CC} \times 0.30$	
				1.4 to 1.6		$V_{CC} \times 0.35$	
				1.65 to 1.95	—	$V_{CC} \times 0.35$	
				2.3 to 2.7	_	0.7	
				3.0 to 3.6	_	0.8	
High-level output voltage	V _{OH}	V _{IN} = V _{IH}	I _{OH} = -0.02 mA	0.9	0.75	_	V
			I _{OH} = -0.3 mA	1.1 to 1.3	$V_{CC} \times 0.75$	_	
			I _{OH} = -1.7 mA	1.4 to 1.6	$V_{CC} \times 0.75$	_	
			I _{OH} = -3.0 mA	1.65 to 1.95	V _{CC} -0.45	_	
			I _{OH} = -4.0 mA	2.3 to 2.7	2.0	_	
			I _{OH} = -8.0 mA	3.0 to 3.6	2.48	_	
Low-level output voltage	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 0.02 mA	0.9	_	0.1	V
			I _{OL} = 0.3 mA	1.1 to 1.3	_	$V_{CC} \times 0.25$	
			I _{OL} = 1.7 mA	1.4 to 1.6	_	$V_{CC} imes 0.25$	
			I _{OL} = 3.0 mA	1.65 to 1.95	_	0.45	
			I _{OL} = 4.0 mA	2.3 to 2.7	_	0.4	
			I _{OL} = 8.0 mA	3.0 to 3.6	_	0.4	
Input leakage current	I _{IN}	V _{IN} = 0 to 3.6 V		0 to 3.6	_	±0.5	μΑ
3-state output OFF-state leakage current	I _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL},$ $V_{OUT} = 0 \text{ to } 3.6 \text{ V}$		0.9 to 3.6	_	±10.0	μA
Power-OFF leakage current	I _{OFF}	V _{IN} = 0 to 3.6 V, V _{OUT} = 0 to 3.6 V		0		10.0	μA
Quiescent supply current	I _{CC}	V _{IN} = V _{CC} or GND		3.6	_	10.0	μA

9.3. DC Characteristics (Unless otherwise specified, $T_a = -40$ to 125 °C)

Characteristics	Symbol	Test Conditio	n	V _{CC} (V)	Min	Max	Unit
High-level input voltage	VIH	—		0.9	V _{CC}	—	V
				1.1 to 1.3	$V_{CC} \times 0.70$	—	
				1.4 to 1.6	$V_{CC} imes 0.65$	—	
				1.65 to 1.95	$V_{CC} imes 0.65$	_	
				2.3 to 2.7	1.7	—	
				3.0 to 3.6	2.0	—	
Low-level input voltage	V _{IL}	—		0.9	—	GND	V
				1.1 to 1.3	—	$V_{CC} \times 0.30$	
				1.4 to 1.6	_	$V_{CC} imes 0.35$	
				1.65 to 1.95	_	$V_{CC} imes 0.35$	
				2.3 to 2.7	_	0.7	
				3.0 to 3.6	_	0.8	
High-level output voltage	V _{OH}	V _{IN} = V _{IH}	I _{OH} = -0.02 mA	0.9	0.75	_	V
			I _{OH} = -0.3 mA	1.1 to 1.3	$V_{CC} imes 0.73$	_	
			I _{OH} = -1.7 mA	1.4 to 1.6	$V_{CC} imes 0.73$	_	
			I _{OH} = -3.0 mA	1.65 to 1.95	V _{CC} -0.5	_	
			I _{OH} = -4.0 mA	2.3 to 2.7	1.95	—	
			I _{OH} = -8.0 mA	3.0 to 3.6	2.4	_	
Low-level output voltage	V _{OL}	$V_{IN} = V_{IH} \text{ or } V_{IL}$	I _{OL} = 0.02 mA	0.9	—	0.1	V
			I _{OL} = 0.3 mA	1.1 to 1.3	—	$V_{CC} \times 0.27$	
			I _{OL} = 1.7 mA	1.4 to 1.6	—	$V_{CC} \times 0.27$	
			I _{OL} = 3.0 mA	1.65 to 1.95	—	0.5	
			I _{OL} = 4.0 mA	2.3 to 2.7	—	0.45	
			I _{OL} = 8.0 mA	3.0 to 3.6	—	0.45	
Input leakage current	I _{IN}	V _{IN} = 0 to 3.6 V		0 to 3.6	_	±2.0	μΑ
3-state output OFF-state leakage current	I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = 0 to 3.6 V		0.9 to 3.6	_	±80.0	μA
Power-OFF leakage current	I _{OFF}	V _{IN} = 0 to 3.6 V V _{OUT} = 0 to 3.6 V		0	—	80.0	μA
Quiescent supply current	I _{CC}	$V_{IN} = V_{CC}$ or GND		3.6	—	80.0	μA



9.4. AC Characteristics (Unless otherwise specified, $T_a = 25$ °C, Input: $t_r = t_f = 3$ ns)

Characteristics	Symbol	Note	Test Condition	V _{CC} (V)	C _L (pF)	Min	Тур.	Max	Unit
Propagation delay time	t _{PLH} ,t _{PHL}		R _L = 1 ΜΩ	0.9	10		20.7	_	ns
				1.1 to 1.3		_	10.5	18.4	
				1.4 to 1.6		_	6.1	8.5	
				1.65 to 1.95		_	4.5	6.2	
				2.3 to 2.7		_	3.0	3.9	
				3.0 to 3.6			2.3	3.1	
			$R_L = 1 M\Omega$	0.9	15		24.5	_	
				1.1 to 1.3			12.7	21.5	
				1.4 to 1.6			7.3	10.1	
				1.65 to 1.95		—	5.4	7.3	
				2.3 to 2.7			3.5	4.5	
				3.0 to 3.6			2.9	3.6	
			R _L = 1 MΩ	0.9	30	_	31.8	_	
				1.1 to 1.3		_	16.3	29.6	
				1.4 to 1.6			9.2	13.1	
				1.65 to 1.95			6.9	9.3	
				2.3 to 2.7		_	4.7	6.4	
				3.0 to 3.6		_	3.8	4.9	
Output enable time	t _{PZL} ,t _{PZH}		R _L = 100 kΩ	0.9	10	_	23.9	—	ns
			$R_L = 5 k\Omega$	1.1 to 1.3		_	11.5	20.3	
				1.4 to 1.6		—	6.2	9.5	
				1.65 to 1.95		_	5.1	7.3	
				2.3 to 2.7		—	3.4	4.6	
				3.0 to 3.6		_	2.9	4.0	
			R _L = 100 kΩ	0.9	15	—	25.2	_	
			$R_L = 5 k\Omega$	1.1 to 1.3		_	12.6	21.3	
				1.4 to 1.6			7.3	10.5	
				1.65 to 1.95			5.5	7.7	
				2.3 to 2.7		_	4.1	5.1	
				3.0 to 3.6		—	3.1	3.9	
			R _L = 100 kΩ	0.9	30		31.0	_	
			$R_L = 5 k\Omega$	1.1 to 1.3		_	16.1	30.7	
				1.4 to 1.6		—	9.2	13.1	
				1.65 to 1.95		_	8.7	11.6	
				2.3 to 2.7		_	4.8	6.0	
				3.0 to 3.6		_	3.9	4.7	
Output disable time	t _{PLZ} ,t _{PHZ}		R _L = 100 kΩ	0.9	10	—	123.5	—	ns
			$R_L = 5 k\Omega$	1.1 to 1.3		—	10.6	16.0	
				1.4 to 1.6		_	6.3	9.1	
				1.65 to 1.95		—	7.3	8.8	
				2.3 to 2.7		_	5.1	6.4	
				3.0 to 3.6			5.8	7.9	
			R _L = 100 kΩ	0.9	15		172.0	_	
			$R_L = 5 k\Omega$	1.1 to 1.3		_	12.2	16.9	
				1.4 to 1.6			7.5	9.8	
				1.65 to 1.95			8.3	9.9	
				2.3 to 2.7		_	6.0	9.4	
				3.0 to 3.6		_	7.1	9.5	



7UL2G126FK

Characteristics	Symbol	Note	Test Condition	V _{CC} (V)	C _L (pF)	Min	Тур.	Max	Unit
Output disable time	t _{PLZ} ,t _{PHZ}		R _L = 100 kΩ	0.9	30	_	266.7	—	ns
			R _L = 5 kΩ	1.1 to 1.3		_	16.9	20.8	
				1.4 to 1.6		_	10.1	13.2	
				1.65 to 1.95		_	12.7	14.6	
				2.3 to 2.7		_	8.6	10.8	
				3.0 to 3.6		_	12.2	14.4	
Input capacitance	C _{IN}		—	3.6	_	_	3	—	pF
Power dissipation capacitance	C _{PD}	(Note 1)	—	0.9 to 3.6	_	_	9		pF

Note 1: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

 $I_{CC(opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$

9.5. AC Characteristics (Unless otherwise specified, T_a = -40 to 85 °C, Input: t_r = t_f = 3 ns)

Characteristics	Symbol	Test Condition	V _{CC} (V)	C _L (pF)	Min	Max	Unit
Propagation delay time	t _{PLH} ,t _{PHL}	R_L = 1 M Ω	0.9	10	_	—	ns
			1.1 to 1.3		1.0	34.2]
			1.4 to 1.6		1.0	10.0]
			1.65 to 1.95		1.0	6.8]
			2.3 to 2.7		1.0	4.7]
			3.0 to 3.6		1.0	3.9]
		R_L = 1 M Ω	0.9	15		—]
			1.1 to 1.3		1.0	37.2	
			1.4 to 1.6		1.0	11.2]
			1.65 to 1.95		1.0	8.6]
			2.3 to 2.7		1.0	5.8]
			3.0 to 3.6		1.0	4.8]
		$R_L = 1 M\Omega$	0.9	30	_	_]
			1.1 to 1.3		1.0	56.0]
			1.4 to 1.6		1.0	15.9]
			1.65 to 1.95	1	1.0	10.6	1
			2.3 to 2.7		1.0	7.3]
			3.0 to 3.6		1.0	5.9]
Output enable time	t _{PZL} ,t _{PZH}	R _L = 100 kΩ	0.9	10		—	ns
		$R_L = 5 k\Omega$	1.1 to 1.3		1.0	29.8	
			1.4 to 1.6		1.0	11.3]
			1.65 to 1.95		1.0	8.3]
			2.3 to 2.7		1.0	5.6]
			3.0 to 3.6]	1.0	4.7]
		R _L = 100 kΩ	0.9	15		_	1
		$R_L = 5 k\Omega$	1.1 to 1.3		1.0	34.7	1
			1.4 to 1.6]	1.0	11.4]
			1.65 to 1.95	1	1.0	8.9	1
			2.3 to 2.7		1.0	6.8	1
			3.0 to 3.6		1.0	4.9	1
		R _L = 100 kΩ	0.9	30	_	_	1
		$R_L = 5 k\Omega$	1.1 to 1.3	1	1.0	50.5	1
			1.4 to 1.6	1	1.0	15.1	1
			1.65 to 1.95	1	1.0	13.8	1

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7UL2G126FK

Characteristics	Symbol	Test Condition	V _{CC} (V)	C _L (pF)	Min	Max	Unit
Output enable time	t _{PZL} ,t _{PZH}	$R_L = 5 k\Omega$	2.3 to 2.7	30	1.0	7.6	ns
			3.0 to 3.6		1.0	6.1	
Output disable time	t _{PLZ} ,t _{PHZ}	R _L = 100 kΩ	0.9	10	_		ns
		$R_L = 5 k\Omega$	1.1 to 1.3		1.0	22.4	
			1.4 to 1.6		1.0	10.4	
			1.65 to 1.95		1.0	9.8	
			2.3 to 2.7		1.0	7.2	
			3.0 to 3.6		1.0	9.3	
		R _L = 100 kΩ	0.9	15	_	_	
		R _L = 5 kΩ	1.1 to 1.3		1.0	25.1	
			1.4 to 1.6		1.0	11.3	
			1.65 to 1.95		1.0	11.1	
			2.3 to 2.7		1.0	12.4	
			3.0 to 3.6	1	1.0	13.2	
		R _L = 100 kΩ	0.9	30		_	
		R _L = 5 kΩ	1.1 to 1.3		1.0	31.9	
			1.4 to 1.6	1	1.0	14.9	
			1.65 to 1.95	1	1.0	16.6	
			2.3 to 2.7		1.0	12.2	
			3.0 to 3.6	1	1.0	16.4	1

9.6. AC Characteristics (Unless otherwise specified, $T_a = -40$ to 125 °C, Input: $t_r = t_f = 3$ ns)

Characteristics	Symbol	Test Condition	V _{CC} (V)	C _L (pF)	Min	Max	Unit
Propagation delay time	t _{PLH} ,t _{PHL}	R_L = 1 M Ω	0.9	10	_	—	ns
			1.1 to 1.3		1.0	44.8	
			1.4 to 1.6		1.0	11.0	
			1.65 to 1.95		1.0	7.2	
			2.3 to 2.7		1.0	5.3	
			3.0 to 3.6		1.0	4.5]
		R_L = 1 M Ω	0.9	15	—	—	
			1.1 to 1.3		1.0	47.7	
			1.4 to 1.6		1.0	12.0	
			1.65 to 1.95		1.0	9.5	
			2.3 to 2.7		1.0	6.7	
			3.0 to 3.6		1.0	5.6	
		R_L = 1 M Ω	0.9	30	_	—	
			1.1 to 1.3		1.0	73.6	
			1.4 to 1.6		1.0	17.8	
			1.65 to 1.95		1.0	11.5	
			2.3 to 2.7		1.0	7.9	
			3.0 to 3.6		1.0	6.6]
Dutput enable time	t _{PZL} ,t _{PZH}	R _L = 100 kΩ	0.9	10	_	_	ns
		$R_L = 5 k\Omega$	1.1 to 1.3		1.0	36.2	
			1.4 to 1.6		1.0	12.5]
			1.65 to 1.95		1.0	9.0	
			2.3 to 2.7		1.0	6.3	
			3.0 to 3.6	1	1.0	5.2	1
		R _L = 100 kΩ	0.9	15		_	
		R _L = 5 kΩ	1.1 to 1.3	1	1.0	43.7	1
			1.4 to 1.6	1	1.0	12.0	1
			1.65 to 1.95		1.0	9.7	
			2.3 to 2.7	1	1.0	11.3	1
			3.0 to 3.6		1.0	5.6	1
		R _L = 100 kΩ	0.9	30		_	
		R _L = 5 kΩ	1.1 to 1.3	1	1.0	63.7	1
			1.4 to 1.6		1.0	16.5	1
			1.65 to 1.95		1.0	15.3	
			2.3 to 2.7	1	1.0	8.7	1
			3.0 to 3.6		1.0	7.1	1
Dutput disable time	t _{PLZ} ,t _{PHZ}	R _L = 100 kΩ	0.9	10	_	—	ns
		R _L = 5 kΩ	1.1 to 1.3	1	1.0	26.7	1
			1.4 to 1.6	1	1.0	11.3	1
			1.65 to 1.95		1.0	10.5	
			2.3 to 2.7	1	1.0	7.8	1
			3.0 to 3.6	1	1.0	10.3	1
		R _L = 100 kΩ	0.9	15	_	_	1
		R _L = 5 kΩ	1.1 to 1.3	1	1.0	30.6	1
			1.4 to 1.6	1	1.0	12.3	1
			1.65 to 1.95	1	1.0	11.9	1
			2.3 to 2.7	1	1.0	14.4	1



7UL2G126FK

Characteristics	Symbol	Test Condition	V _{CC} (V)	C _L (pF)	Min	Max	Unit
Output disable time	t _{PLZ} ,t _{PHZ}	R _L = 5 kΩ	3.0 to 3.6	15	1.0	15.7	ns
		R _L = 100 kΩ	0.9	30	_	_	
		R _L = 5 kΩ	1.1 to 1.3	1	1.0	39.3	
			1.4 to 1.6	1	1.0	16.1	
			1.65 to 1.95	1	1.0	18.0	
			2.3 to 2.7]	1.0	13.2	
			3.0 to 3.6]	1.0	17.8	

9.7. AC Test Circuit

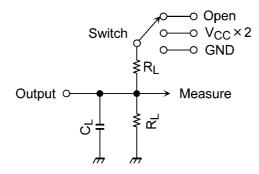


Table 9.7.1 Parameter for AC Test Circuit

Characteristics	Switch	
t _{PLH} , t _{PHL}	Open	
t _{PLZ} , t _{PZL}	$V_{CC} \times 2$	
t _{PHZ} , t _{PZH}	GND	

9.8. AC Waveform

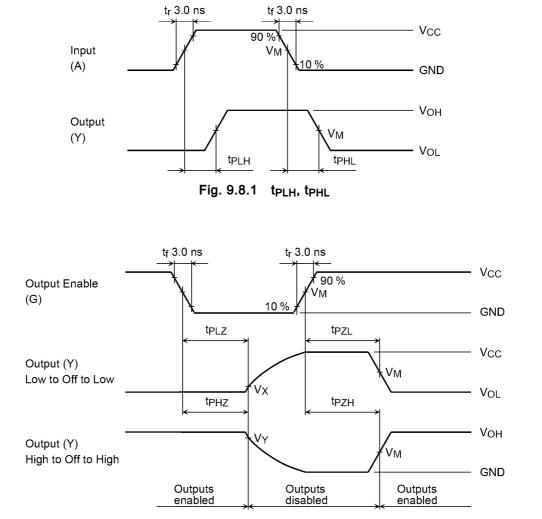


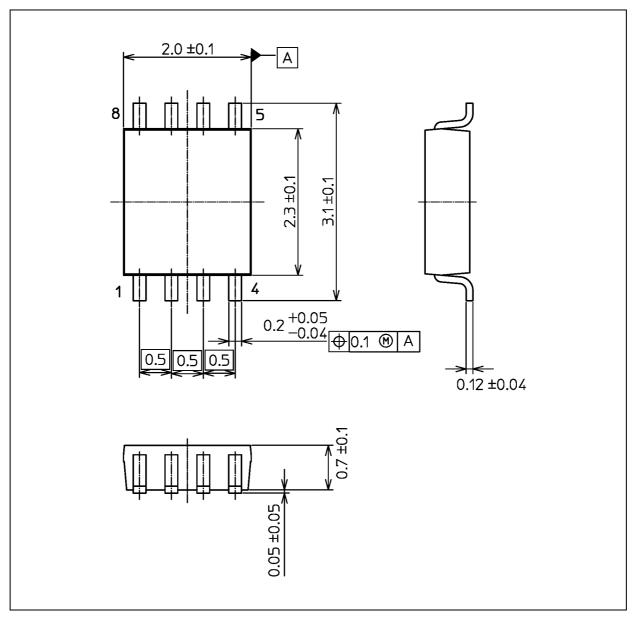
Fig. 9.8.2 t_{PLZ}, t_{PHZ}, t_{PZL}, t_{PZH}

Symbol	V _{CC} = 3.3 ± 0.3 V	V _{CC} = 2.5 ± 0.2 V	V _{CC} = 1.8 ± 0.15 V	V _{CC} = 1.5 ± 0.1 V	V _{CC} = 1.2 ± 0.1 V	V _{CC} = 0.9 V
V _M	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2
V _X	V _{OL} + 0.3 V	V _{OL} + 0.15 V	V _{OL} + 0.15 V	V _{OL} + 0.1 V	V _{OL} + 0.1 V	V _{OL} + 0.1 V
V _Y	V _{OH} - 0.3 V	V _{OH} - 0.15 V	V _{OH} - 0.15 V	V _{OH} - 0.1 V	V _{OH} - 0.1 V	V _{OH} - 0.1 V

7UL2G126FK

Package Dimensions

Unit: mm



Weight: 0.01 g (typ.)

Package Name(s)			
JEDEC: SOT-765			
Nickname: US8			

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